AUG 0 1 2000

Sheet 1 of 2

Form PTO-1	F	örn	a P	TO	-1	44	9
------------	---	-----	-----	----	----	----	---

U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK CENTERS

ATTY. DKT. NO. SERIAL-NO. SCH 1742 09/485,292

APPLICANT

Ulrich Khan et al. FILING DATE

GROUP

(Use several sheets if necessary)

INFORMATION DISCLOSURE STATEMENT BY APPLICANT

3 May 2000

1914 /10

U.S. PATENT DOCUMENTS

Examiner Initial		Document Number	Date	Name	Class	Subclass	Filing Date
	AA						
	AB						
	AC						

FOREIGN PATENT DOCUMENTS

Examiner Initial		Document Number	Doto Country	Class	Subclass	Translation		
Initial		Number	Date	Country	Class Subcl		Yes	No
BUIL	AM	- 4138042	5/27/93	DE				
BMM	AN	19636343	10/23/97	DE				
Bull	··AO -	19701758	7/23/98	DE				
POMP	AP	9719086	5/29/1997	wo				
PSW	- AQ	9808849	3/5/98	wo				
	AR							
	AS							
	AT							

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

Byr	AU	W. CLARK STILL ET AL.: TETRAHEDRON LETTERS, Bd. 21, 1980, Seiten 1031-4, XP002095727
BUR	AV	K. A. PARKER ET AL.: JOURNAL OF ORGANIC CHEMISTRY, Bd. 52, Nr. 19, 1987, Seiten 4369-77, XP002095726
Bun	AW	K. TAMAO ET AL.: JOURNAL OF THE CHEMICAL SOCIETY, CHEMICAL COMMUNICATIONS,1988, Seiten 795-7, XP002095725
Bun	AX	D. SCHINZER ET AL.: CHEMISTRY - A EUROPEAN JOURNAL, Bd. 2, Nr. 11, 1996, Seiten 1477-82, XP002095724 in der Anmeldung erwaehnt
Bun	AY	K. C. NICOLAOU ET AL.: ANGEWANDTE CHEMIE, Bd. 109, Nr. 19, 1997, Seiten 2181-7, XP002095723 in der Anmeldung erwaehnt
BMPZ	AZ	K. C. NICOLAOU ET AL.: JOURNAL OF THE AMERICAN CHEMICAL SOCIETY, Bd. 119, Nr. 34, 1997, Seiten 7974-91, XP002095719 in der Anmeldung erwaehnt
Examine	er	Buto Polynson Date Considered 8/23/02

		$\langle \alpha \rangle \rangle \langle \alpha \rangle = -1$		
Form PTO-1449	U.S. DEPARTMENT O PATENT AND TRADE	F COMMERCE A	ATTY. DKT. NO.	SERIAL NO.
			SCH-1-742	09/485 , 292
	ţ	AUG 0 1 2000	APPLICANT	
INFORMATI	ON DISCLOSURE STA BY APPLICANT	EMENT 4	Ulrich Khan et al.	
		RADEMARK	FILING DATE	GROUP (6)
(Us	e several sheets if necessary)		3 May 2000	16/14

U.S. PATENT DOCUMENTS

Examiner Initial	Document Number	Date	Name	Class	Subclass	Filing Date
AA	Ţ					
AB						
AC		T				
AD				REC.		
AE				'CQ	FVI	<u></u>
AF				Alic	D3A	
AG				AUG 03	Zan	
AH	<u> </u>			ECH OFNIT		-
AI				TECH OF NOTE 1600	200	
AJ					100	
AK						
AL						

FOREIGN PATENT DOCUMENTS

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

	0.	HER DOCOMENTS (including Author, Title, Date, Tertinent Lages, Dec.)
Byr	AU	ZHEN YANG ET AL.: ANGEWANDTE CHEMIE, Bd. 109, Nr. 1/2, 1997, Seiten 170-2, XP002095722 in der Anmeldung erwaehnt
BUR	AV	K. C. NICOLAOU ET AL.: NATURE, Bd. 387, Nr. 6630, 15. Mai 1997, Seiten 268-72, XP002095721 in der Anmeldung erwaehnt
BMI	AW C	D. SCHINZER ET AL.: ANGEWANDTE CHEMIE, Bd. 109, Nr. 5, 1997, Seiten 543-4, XP002095720 in der Anmeldung erwaehnt
BUJO	AX	K. C. NICOLAOU: JOURNAL OF THE AMERICAN-CHEMICAL SOCIETY, Bd. 119, Nr. 34, 1997, Seiten 7960-73, XP002064442 in der Anmeldung erwaehnt
	AY	
	AZ	
Examin	er	Sinte Molinson Date Considered 8 123 102